

TEST REPORT

APPLICANT : Sharp Corporation, Communication Systems Group
ADDRESS : 2-13-1, Iida Hachihonmatsu, Higashi-Hiroshima City, Hiroshima,
739-0192, JAPAN
PRODUCTS : Cellular Phone
MODEL NO. : CDMA SH009
SERIAL NO. : SSHDX000624
FCC ID : APYHRO00127
TEST STANDARD : CFR 47 FCC Rules and Regulations Part 22
TESTING LOCATION : Japan Quality Assurance Organization
KITA-KANSAI Testing Center
1-7-7, Ishimaru, Minoh-shi, Osaka 562-0027, Japan
TEST RESULTS : **Passed**
DATE OF TEST : July 26, 2010 ~ August 19, 2010

This report must not be used by the client to
claim product endorsement by NVLAP or
NIST or any agency of the U.S. Government.



NVLAP LAB CODE 200191-0

Kousei Shibata

Manager

Japan Quality Assurance Organization

KITA-KANSAI Testing Center

Testing Dept. EMC Division

1-7-7, Ishimaru, Minoh-shi, Osaka 562-0027, Japan

-
- The measurement values stated in Test Report was made with traceable to National Institute of Advanced Industrial Science and Technology (AIST) of Japan and National Institute of Information and Communications Technology (NICT) of Japan.
 - The applicable standard, testing condition and testing method which were used for the tests are based on the request of the applicant.
 - The test results presented in this report relate only to the offered test sample.
 - The contents of this test report cannot be used for the purposes, such as advertisement for consumers.
 - This test report shall not be reproduced except in full without the written approval of JQA.

TABLE OF CONTENTS

	Page
Documentation	3
1 Test Regulation.....	3
2 Test Location.....	3
3 Recognition of Test Laboratory.....	3
4 Description of the Equipment Under Test.....	4
5 Test Condition.....	5
6 Preliminary Test and Test Setup	7
7 Equipment Under Test Modification.....	16
8 Responsible Party	16
9 Deviation from Standard.....	16
10 Test Results.....	17
11 Summary	20
12 Operating Condition.....	21
13 Test Configuration.....	21
14 Equipment Under Test Arrangement (Drawings)	22
Appendix A: Test Data	23
Appendix B: Test Arrangement (Photographs)	40
Appendix C: Test Instruments.....	42

DEFINITIONS FOR ABBREVIATION AND SYMBOLS USED IN THIS TEST REPORT

EUT : Equipment Under Test	EMC : Electromagnetic Compatibility
AE : Associated Equipment	EMI : Electromagnetic Interference
N/A : Not Applicable	EMS : Electromagnetic Susceptibility
N/T : Not Tested	

- ☒ - indicates that the listed condition, standard or equipment is applicable for this report.
☐ - indicates that the listed condition, standard or equipment is not applicable for this report.

Documentation

1 Test Regulation

Applied Standard : CFR 47 FCC Rules and Regulations Part 22
Subpart H – Cellular Radiotelephone Service

Test Requirements : CFR 47 FCC Rules and Regulations Part 2
§2.1046, §2.1047, §2.1049, §2.1051, §2.1053, §2.1055 and §2.1057

Test Procedure : ANSI C63.4–2003, TIA/EIA–603-C-2004

2 Test Location

KITA-KANSAI Testing Center
1-7-7, Ishimaru, Minoh-shi, Osaka 562-0027, Japan
KAMEOKA EMC Branch
9-1, Ozaki, Inukanno, Nishibetsuin-cho, Kameoka-shi, Kyoto 621-0126, Japan

3 Recognition of Test Laboratory

JQA KITA-KANSAI Testing Center Testing Department EMC Division is accredited under ISO/IEC 17025 by following accreditation bodies and the test facility of Testing Division is registered by the following bodies.

VLAC Code : VLAC-001-2 (Effective through : March 30, 2012)
NVLAP Lab Code : 200191-0 (Effective through : June 30, 2011)
BSMI Recognition No. : SL2-IS-E-6006, SL2-IN-E-6006, SL2-AI-E-6006
(Effective through : September 14, 2010)

VCCI Registration No. : R-008, C-006, C-007, C-1674, C-2143, C-3685, T-1418, T-1419, T-1819, T-1820,
T-1821, G-172, G-173
(Effective through : March 30, 2012)

IC Registration No. : 2079E-1, 2079E-2 (Effective through : January 6, 2011)

Accredited as conformity assessment body for Japan electrical appliances and material law by METI.
(Effective through : February 22, 2012)

4 Description of the Equipment Under Test

4.1 General Information

1. Manufacturer : Sharp Corporation, Communication Systems Group
2-13-1, Iida Hachihonmatsu, Higashi-Hiroshima City, Hiroshima,
739-0192, JAPAN
2. Products : Cellular Phone
3. Model No. : CDMA SH009
4. Serial No. : SSHDX000624
5. Product Type : Pre-production
6. Date of Manufacture : June, 2010
7. Transmitting Frequency : 824.70MHz(1013CH) – 848.37MHz(779CH)
8. Receiving Frequency : 869.70MHz(1013CH) – 893.37MHz(779CH)
9. Emission Designations : 1M28F9W
10. Max. RF Output Power : 0.646W (ERP)
11. Power Rating : 4.0VDC (Lithium-ion Battery Pack SH009UAA 800mAh)
12. EUT Grounding : None
13. Category : CDMA2000
14. EUT Authorization : Certification
15. Receive Date of EUT : July 15, 2010

4.2 Channel Plan

The carrier spacing is 30 kHz.

The carrier frequency is designated by the absolute frequency channel number (ARFCN).

The carrier frequency is expressed in the equation shown as follows:

$$\text{Transmitting Frequency (in MHz)} = 824.70 + 0.03 \times (n - 1013)$$

where, n : channel number ($1013 \leq n \leq 1023$)

$$\text{Transmitting Frequency (in MHz)} = 825.03 + 0.03 \times (n - 1)$$

where, n : channel number ($1 \leq n \leq 311$)

$$\text{Transmitting Frequency (in MHz)} = 835.68 + 0.03 \times (n - 356)$$

where, n : channel number ($356 \leq n \leq 644$)

$$\text{Transmitting Frequency (in MHz)} = 845.67 + 0.03 \times (n - 689)$$

where, n : channel number ($689 \leq n \leq 779$)

$$\text{Receiving Frequency (in MHz)} = 869.70 + 0.03 \times (n - 1013)$$

where, n : channel number ($1013 \leq n \leq 1023$)

$$\text{Receiving Frequency (in MHz)} = 870.03 + 0.03 \times (n - 1)$$

where, n : channel number ($1 \leq n \leq 311$)

$$\text{Receiving Frequency (in MHz)} = 880.68 + 0.03 \times (n - 356)$$

where, n : channel number ($356 \leq n \leq 644$)

$$\text{Receiving Frequency (in MHz)} = 890.67 + 0.03 \times (n - 689)$$

where, n : channel number ($689 \leq n \leq 779$)

5 Test Condition**5.1 RF Power Output (§2.1046)****5.1.1 Conducted RF Power Output**

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

Test site : KITA-KANSAI ☒ - Shielded room ☐ - 2nd Shielded room
KAMEOKA ☐ - Shielded room ☐ - Conducted emission facility

Test instruments : Refer to Appendix C.

5.1.2 ERP / EIRP RF Power Output

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

Test site : ☒ - KAMEOKA 1st open site ☒ - 3 m ☐ - 10 m
☐ - KAMEOKA 2nd open site ☐ - 3 m ☐ - 10 m

Test instruments : Refer to Appendix C.

5.2 Modulation Characteristics (§2.1047)

The requirements are ☐ - Applicable ☐ - Tested. ☐ - Not tested by applicant request.]
☒ - Not Applicable

Test site : KITA-KANSAI ☐ - Shielded room ☐ - Anechoic chamber
KAMEOKA ☐ - Shielded room

Test instruments : Refer to Appendix B.

5.3 Occupied Bandwidth (§2.1049)

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

Test site : KITA-KANSAI ☒ - Shielded room ☐ - 2nd Shielded room
KAMEOKA ☐ - Shielded room ☐ - Conducted emission facility

Test instruments : Refer to Appendix C.

5.4 Spurious Emissions at Antenna Terminals (§2.1051)

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

Test site : KITA-KANSAI ☒ - Shielded room ☐ - 2nd Shielded room
KAMEOKA ☐ - Shielded room ☐ - Conducted emission facility

Test instruments : Refer to Appendix C.

5.5 Band-Edge Emission (§2.1051)

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

Test site : KITA-KANSAI ☒ - Shielded room ☐ - 2nd Shielded room
KAMEOKA ☐ - Shielded room ☐ - Conducted emission facility

Test instruments : Refer to Appendix C.

5.6 Field Strength of Spurious Radiation (§2.1053)

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

Test site : ☒ - KAMEOKA 1st open site ☒ - 3 m ☐ - 10 m
☐ - KAMEOKA 2nd open site ☐ - 3 m ☐ - 10 m

Test instruments : Refer to Appendix C.

5.7 Frequency Stability (§2.1055)

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

Test site : KITA-KANSAI Environment Testing Room

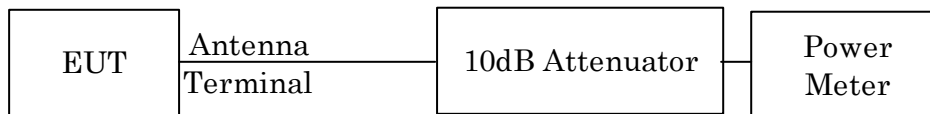
Test instruments : Refer to Appendix C.

6 Preliminary Test and Test Setup

6.1 RF Power Output (§2.1046)

6.1.1 Conducted RF Power Output

The Conducted RF Power Output was measured with a power meter, one 10dB attenuator and a short, low loss cable.



6.1.2 ERP / EIRP RF Power Output

Step 1:

In order to obtain the maximum emission, the EUT was placed at the height 1.8 m on the non-conducted support and was varying at three orthogonal axes (Refer to clause 15), at the distance 3 m from the receiving antenna and rotated around 360 degrees.

The receiving antenna height was varied from 1 m to 4 m.

The EUT on the table was placed to be maximum emission against at the receiving antenna polarized (vertical and horizontal).

Then the meter reading of the spectrum analyzer at the maximum emission was A dB(μV).

Step 2:

The EUT was replaced to substitution antenna at the same polarized under the same condition as step 1.

The RF power was fed to the transmitting antenna through the RF amplifier from the signal generator.

In order to obtain the maximum emission level, the height of the receiving antenna was varied from 1 m to 4 m.

The level of maximum emission was A dB(μV), same as the recorded level in the step 1.

Then the RF power into the substitution horn antenna was P (dBm).

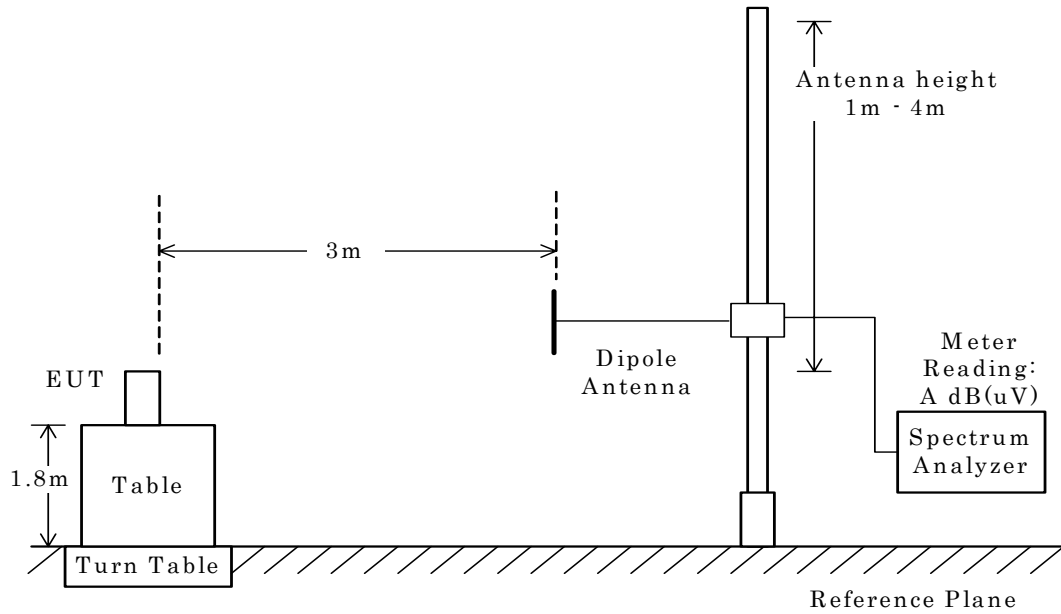
The ERP/EIRP output power was calculated in the following equation.

$$\text{ERP (dBm)} = P \text{ (dBm)} - \text{Balun loss of the tuned dipole antenna (dB)} + \text{Cable loss (dB)}$$

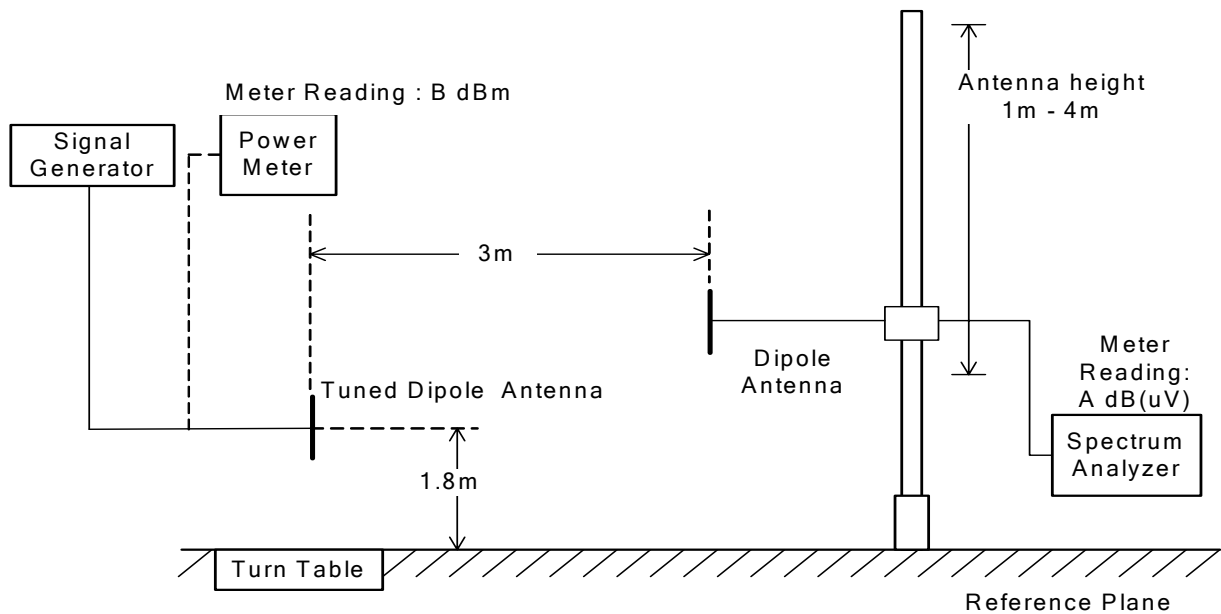
$$\text{EIRP (dBm)} = P \text{ (dBm)} + G_h \text{ (dBi)}$$

where, $G_h \text{ (dBi)}$: Gain of the substitution horn antenna.

– Side View –



(a)EUT



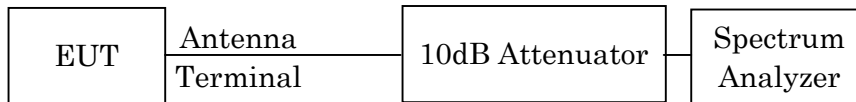
(b) Substitution Half-wave Dipole Antenna

6.2 Modulation Characteristics (§2.1047)

Not Applicable

6.3 Occupied Bandwidth (§2.1049)

The test system is shown as follows:



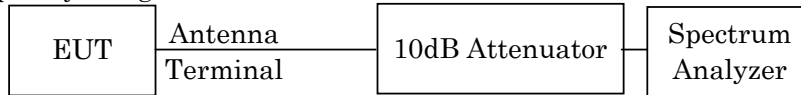
The setting of the spectrum analyzer are shown as follows:

Res. Bandwidth	30 kHz
Video Bandwidth	30 kHz
Span	3 MHz
Sweep Time	AUTO
Trace	Maxhold

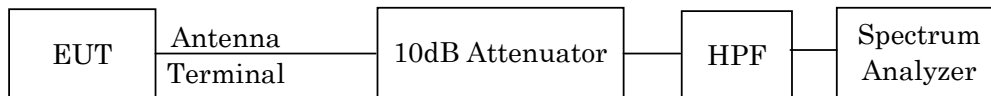
6.4 Spurious Emissions at Antenna Terminals (§2.1051)

The Antenna Conducted Emission was measured with a spectrum analyzer. The test system is shown as follows:

a) Frequency Range : 9kHz - 1.2GHz



b) Frequency Range : 1.2GHz - 10GHz

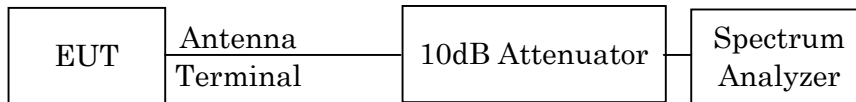


The setting of the spectrum analyzer are shown as follows:

Frequency Range	9 kHz - 150 kHz	150 kHz - 30 MHz	30 MHz - 10 GHz
Res. Bandwidth	200 Hz	10 kHz	1 MHz
Video Bandwidth	1 kHz	30 kHz	3 MHz
Sweep Time	AUTO	AUTO	AUTO
Trace	Maxhold	Maxhold	Maxhold

6.5 Band-Edge Emission (§2.1051)

The test system is shown as follows:



The setting of the spectrum analyzer are shown as follows:

TX Frequency	824.70 MHz / 848.37 MHz
Band-Edge Frequency	824.00 MHz / 849.00 MHz
Res. Bandwidth	51 kHz
Video Bandwidth	51 kHz
Span	5 MHz
Sweep Time	AUTO
Trace	Maxhold

6.6 Field Strength of Spurious Radiation (§2.1053)

Step 1) The spurious radiation for transmitter were measured at the distance 3 m away from the EUT which was placed on a non-conducted support 1.0 m in height and was varying at three orthogonal axes (Refer to clause 15). The receiving antenna was oriented for vertical polarization and varied from 1 m to 4 m until the maximum emission level was detected on the measuring instrument. The EUT was rotated 360 degrees until the maximum emission was received. The measurement was also repeated with the receiving antenna in the horizontal polarization.

This test was carried out using the half-wave dipole antenna for up to 1GHz and using the horn antenna for above 1 GHz.

Step 2) The ERP measurement was carried out with according to Step 2 in page 8. Then the RF power in the substitution antenna half-wave dipole antenna for up to 1 GHz and the substitution horn antenna for above 1 GHz.

The ERP is calculated in the following equation.

A) Up to 1 GHz

$$\text{ERP(dBm)} = P \text{ (dBm)} - (\text{Balun Loss of the half-wave dipole Ant. (dB)}) + \text{Cable Loss (dB)}$$

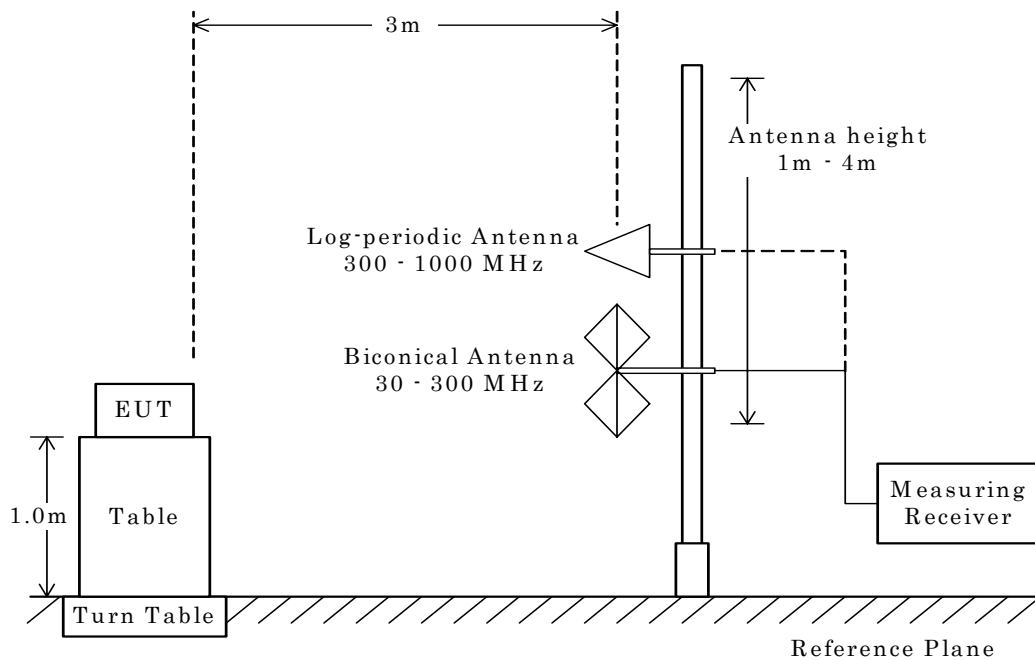
B) Above 1 GHz

$$\text{ERP(dBm)} = P \text{ (dBm)} + G_h \text{ (dBi)} - G_d \text{ (dBi)}$$

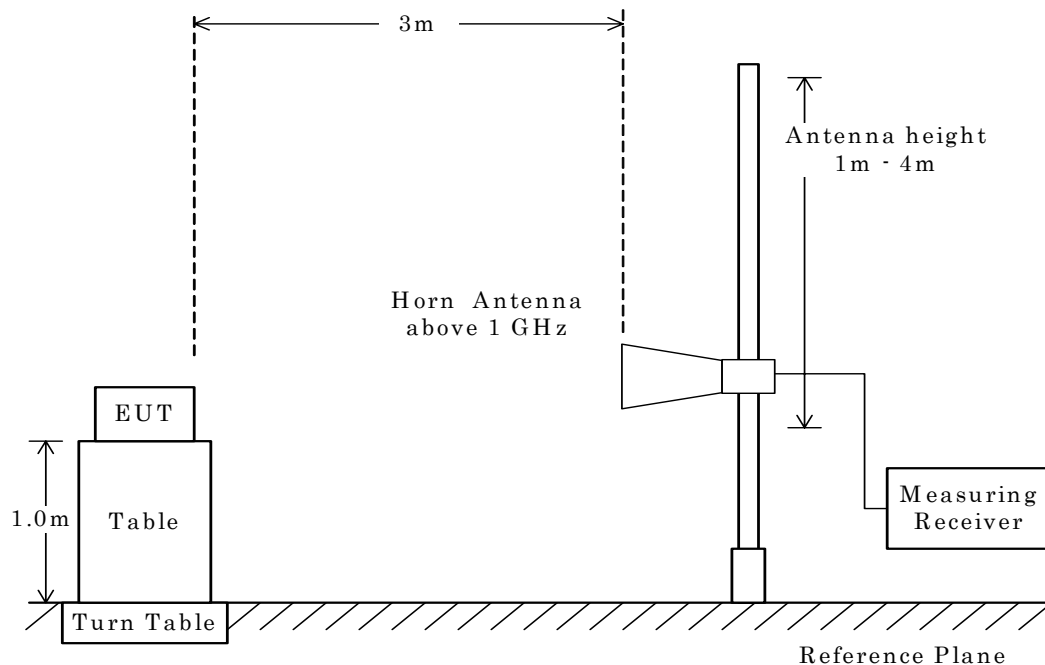
Where, $G_h \text{ (dBi)}$: Gain of the substitution horn antenna
 $G_d \text{ (dBi)}$: Gain of the substitution half-wave dipole antenna

The respective calculated ERP of the spurious and harmonics were compared with the ERP of fundamental frequency by specified attenuation limits, $43 + 10 \log_{10} (\text{TP in watt}) [\text{dB}]$. Where, TP = Transmitter power at the ANT OUT under test configuration as the hands free unit used.

Radiated Emission 30 MHz to 1000 MHz



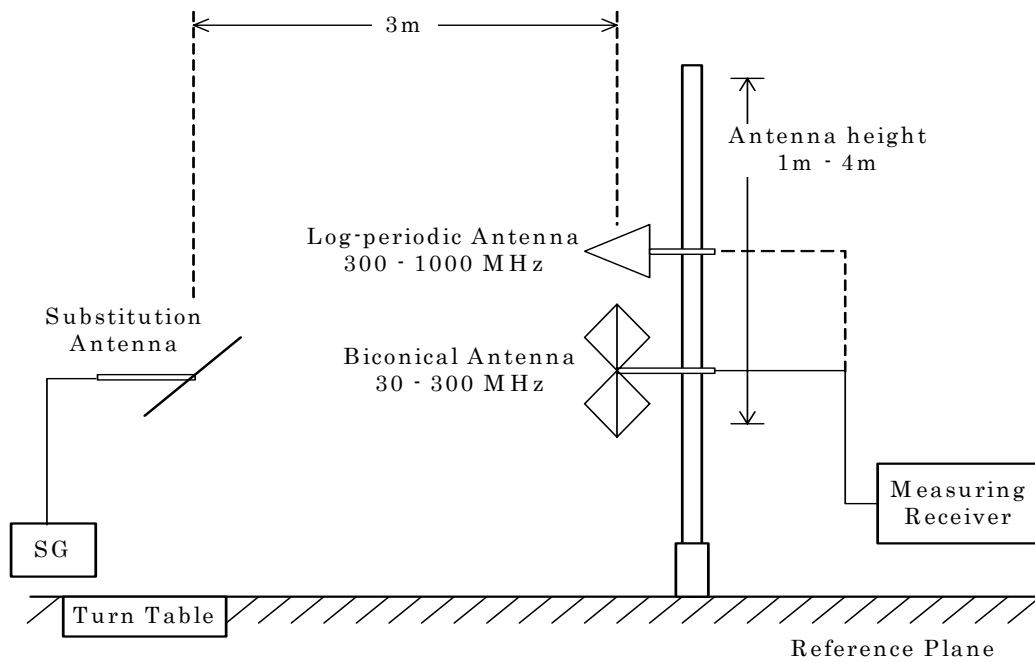
Radiated Emission above 1 GHz



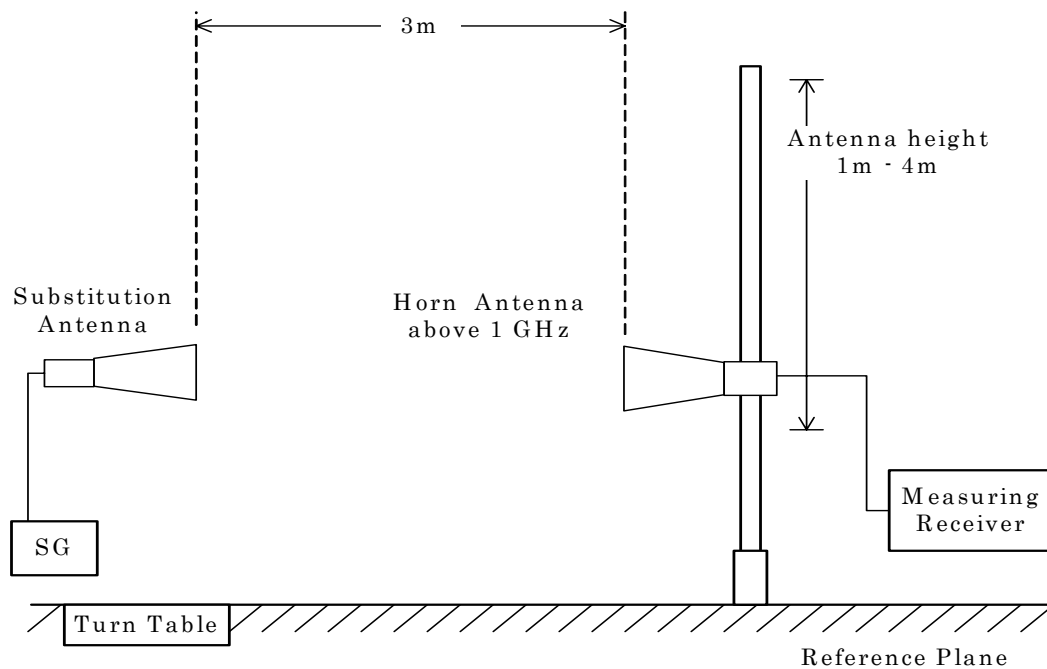
NOTE

The antenna height is scanned depending on the EUT's size and mounting height.

Radiated Emission 30 to 1000 MHz – Substitution Method



Radiated Emission above 1 GHz – Substitution Method



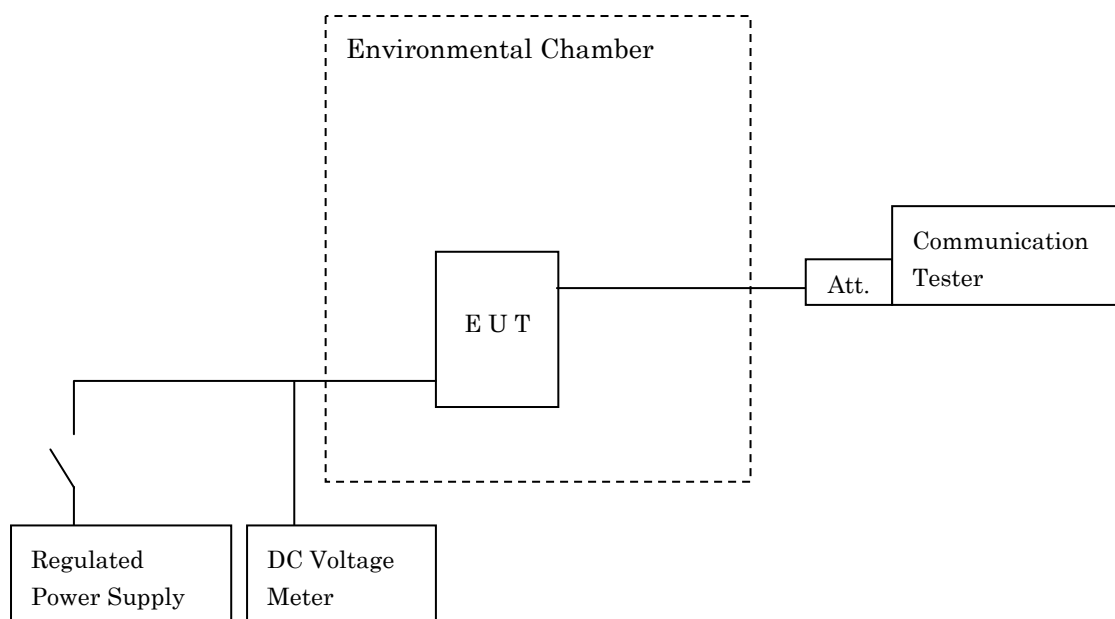
6.7 Frequency Stability (§2.1055)

Frequency Stability versus Temperature

The EUT was placed in an environmental chamber and was tested in the range from –30 to +50 degrees Celsius. The EUT was stabilized at each temperature. The power (4.0VDC) supplied was applied to the transmitter and allowed to stabilize for 10 minutes. The transmitting frequency was measured at startup and 2 minutes, 5 minutes and 10 minutes after startup. This procedure was repeated from –30 to +50 degrees Celsius at the interval of 10 degrees.

Frequency Stability versus Power Supply Voltage

The EUT was placed in an environmental chamber and was tested at the temperature of +20 degrees Celsius. The EUT was stabilized at the temperature. The power (4.0VDC) and the power (3.7VDC, the ending voltage) was applied to the EUT allowed to stabilize for 10 minutes. The transmitting frequency was measured at startup and 2 minutes, 5 minutes and 10 minutes after startup.



7 Equipment Under Test Modification

- ☒ - No modifications were conducted by JQA to achieve compliance to the limitations.
☐ - To achieve compliance to the limitations, the following changes were made by JQA during the compliance test.

The modifications will be implemented in all production models of this equipment.

Applicant : Not Applicable

Date : Not Applicable

Typed Name : Not Applicable

Position : Not Applicable

Signatory : Not Applicable

8 Responsible PartyResponsible Party of Test Item (Product)

Responsible Party :

Contact Person :

Signatory

9 Deviation from Standard

- ☒ - No deviations from the standard described in clause 1.
☐ - The following deviations were employed from the standard described in clause 1.

10 Test Results**10.1 RF Power Output (§2.1046)****10.1.1 Conducted RF Power Output**

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

Transmitter Power is 867.0 mW at 824.700 MHz(Peak)
238.2 mW at 824.700 MHz(Average)

Uncertainty of Measurement Results at Amplitude +/-0.19 dB(2 σ)

Remarks : _____

10.1.2 ERP / EIRP RF Power Output

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

☒ - Passed ☐ - Failed ☐ - Not judged

Min. Limit Margin 10.4 dB at 824.700 MHz

Max. Limit Exceeding _____ dB at _____ MHz

Uncertainty of Measurement Results at Amplitude +1.4/-1.3 dB(2 σ)

Remarks : The maximum ERP is 0.646 W at 824.700MHz.

10.2 Modulation Characteristics (§2.1047)

The requirements are ☐ - Applicable ☐ - Tested. ☐ - Not tested by applicant request.]
☒ - Not Applicable

☐ - Passed ☐ - Failed ☐ - Not judged

Remarks : _____

10.3 Occupied Bandwidth (§2.1049)

The requirements are ☒ - Applicable [☐ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

☒ - Passed ☐ - Failed ☐ - Not judged

The 99% Bandwidth is 1.28 MHz at 836.520 MHz
The 26dB Bandwidth is 1.43 MHz at 824.700 MHz

Uncertainty of Measurement Results at Frequency +/-1.7 kHz(2σ)
Uncertainty of Measurement Results at Amplitude +/-0.24 dB(2σ)

Remarks : _____

10.4 Spurious Emissions at Antenna Terminals (§2.1051)

The requirements are ☒ - Applicable [☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

☒ - Passed ☐ - Failed ☐ - Not judged

Min. Limit Margin 19.6 dB at 2474.100 MHz

Max. Limit Exceeding _____ dB at _____ MHz

Uncertainty of Measurement Results at Amplitude +/-0.24 dB(2σ)

Remarks : _____

10.5 Band-Edge Emission (§2.1051)

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

☒ - Passed ☐ - Failed ☐ - Not judged

The Band-Edge level is N/A dBc at N/A MHz

Uncertainty of Measurement Results at Frequency +/-1.7 kHz(2σ)
 Uncertainty of Measurement Results at Amplitude +/-0.24 dB(2σ)

Remarks : _____

10.6 Field Strength of Spurious Radiation (§2.1053)

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

☒ - Passed ☐ - Failed ☐ - Not judged

Min. Limit Margin 24.7 dB at 3346.080 MHz

Max. Limit Exceeding dB at MHz

Uncertainty of Measurement Results 30 MHz – 1000 MHz +1.4/-1.3 dB(2σ)
 above 1 GHz +/-1.3 dB(2σ)

Remarks : _____

10.7 Frequency Stability (§2.1055)

The requirements are ☒ - Applicable ☒ - Tested. ☐ - Not tested by applicant request.]
☐ - Not Applicable

The Frequency Stability level is +0.05 ppm at 836.400 MHz

Uncertainty of Measurement Results +/-10 Hz(2σ)

Remarks : _____

11 Summary**General Remarks :**

The EUT was tested according to the requirements of the following standard.

CFR 47 FCC Rules and Regulations Part 22

The test configuration is shown in clause 12 to 14.

The conclusion for the test items of which are required by the applied regulation is indicated under the test results.

Determining compliance with the limits in this report was based on the results of the compliance measurement, not taking into account measurement instrumentation uncertainty.

Test Results :

The “as received” sample;

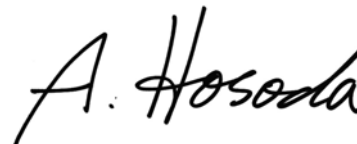
- ☒ - fulfill the test requirements of the regulation mentioned on clause 1.
- ☐ - doesn't fulfill the test requirements of the regulation mentioned on clause 1.

Reviewed by:

Tested by:



Shigeru Kinoshita
Deputy Manager
Testing Dept. EMC Div.
JQA KITA-KANSAI Testing Center



Akio Hosoda
Advisor
Testing Dept. EMC Div.
JQA KITA-KANSAI Testing Center

12 Operating Condition

The test were carried under one modulation type shown as follows:

Modulation Data : BPSK Spreading : HPSK

The Radiated Emission test were carried under 3 test configurations shown in clause 14.

In all tests, the fully charged battery is used for the EUT.

Detailed Transmitter portion:

Transmitter frequency : 824.700 MHz(1013CH) – 848.370 MHz(779CH)

Local frequency : 3298.800 MHz(1013CH) – 3393.480 MHz(779CH)

Detailed Receiver portion:

Receiver frequency : 869.700 MHz(1013CH) – 893.370MHz(779CH)

Local frequency : 3478.800 MHz(1013CH) – 3573.480MHz(779CH)

Other Clock Frequency

19.2 MHz, 32.768 kHz

13 Test Configuration

The equipment under test (EUT) consists of :

	Item	Manufacturer	Model No.	Serial No.	FCC ID
A	Cellular Phone	Sharp	CDMA SH009	SSHDX00 0624	APYHRO00127
B	Lithium-ion Battery	Sharp	SH009UAA	--	N/A
C	AC Adapter	MITSUMI	0203PQA	--	N/A
D	Stereo Earphone	SONY	MDR-E0921SP/B C	--	N/A
E	Arib Connector Adaptor	SMK	--	--	N/A

The auxiliary equipment used for testing :

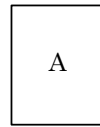
None

Type of Cable:

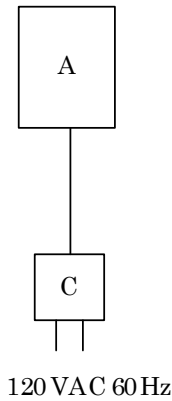
No.	Description	Identification (Manu. etc.)	Connector Shielded	Cable Shielded	Ferrite Core	Length (m)
1	DC Power Cord	--	--	NO	NO	1.4
2	Stereo Earphone Cable	--	--	NO	NO	0.9
3	Arib Connector Cable	--	--	NO	NO	0.1

14 Equipment Under Test Arrangement (Drawings)

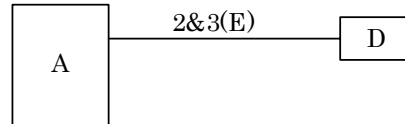
a) Single Unit



b) AC Adapter used



c) Stereo Earphone used



Appendix A: Test Data

A.1 RF Power Output (§2.1046)

A.1.1 Conducted RF Power Output

(CDMA2000)

Test Date: August 6, 2010
 Temp.: 26 °C, Humi: 51 %

Transmitting Frequency CH	[MHz]	Correction Factor [dB]	Meter Reading (Peak) [dBm]	Results (Peak) [dBm]	[mW]
1013	824.700	10.81	18.57	29.38	867.0
384	836.520	10.81	18.21	29.02	798.0
779	848.370	10.82	18.22	29.04	801.7
Transmitting Frequency CH	[MHz]	Correction Factor [dB]	Meter Reading (Average) [dBm]	Results (Average) [dBm]	[mW]
1013	824.700	10.81	12.96	23.77	238.2
384	836.520	10.81	12.61	23.42	219.8
779	848.370	10.82	12.90	23.72	235.5

Calculated result at 824.700 MHz, as the maximum level point shown on underline:

Correction Factor	=	10.81	dB
+) Meter Reading	=	18.57	dBm
Result	=	29.38	dBm = 867.0 mW

NOTE : The correction factor shows the attenuation pad loss including the short, low loss cable or adapter.

A.1.2 ERP /EIRP Power Output

(CDMA2000)

Test Date: August 11, 2010
 Temp.: 25 °C, Humi: 50 %

1. Measurement Results

CH	Transmitting Frequency [MHz]	Emission Measurement [dB(uV)]		Substitution Measurement [dB(uV)]		Supplied Power to Substitution Antenna [dBm]	Balun Loss of Substitution Antenna [dB]
		Hori. (Mh)	Vert. (Mv)	Hori. (Msh)	Vert. (Msv)		
1013	824.700	95.4	92.3	65.3	63.7	- 0.6	1.4
384	836.520	94.6	91.5	64.9	62.6	- 0.6	1.4
779	848.370	94.7	91.3	64.8	63.2	- 0.6	1.4

2. Calculation Results

CH	Transmitting Frequency [MHz]	Peak ERP [dBm]		Maximum Peak ERP [W]	Limits [dBm]	Margin [dB]
		Hori. (ERPh)	Vert. (ERPv)			
1013	824.700	28.1	26.6	0.646	38.5	+10.4
384	836.520	27.7	26.9	0.589	38.5	+10.8
779	848.370	27.9	26.1	0.617	38.5	+10.6

Calculated result at 824.700 MHz, as the worst point shown on underline:

Emission Measurement (Mh)	=	95.4 dB(uV)
Substitution Measurement (Msh)	=	-65.3 dB(uV)
Supplied Power to Substitution Antenna	=	-0.6 dBm
+) Balun Loss of Substitution Antenna	=	-1.4 dB
Result (ERPh)	=	28.1 dBm = 0.646 W

Minimum Margin: 38.5 - 28.1 = 10.4 (dB)

NOTE : Setting of measuring instrument(s) :

Detector Function	Resolution B.W.	V.B.W.	Sweep Time
Peak	5 MHz	5 MHz	AUTO

A.2 Modulation Characteristics (§2.1047)

Not Applicable

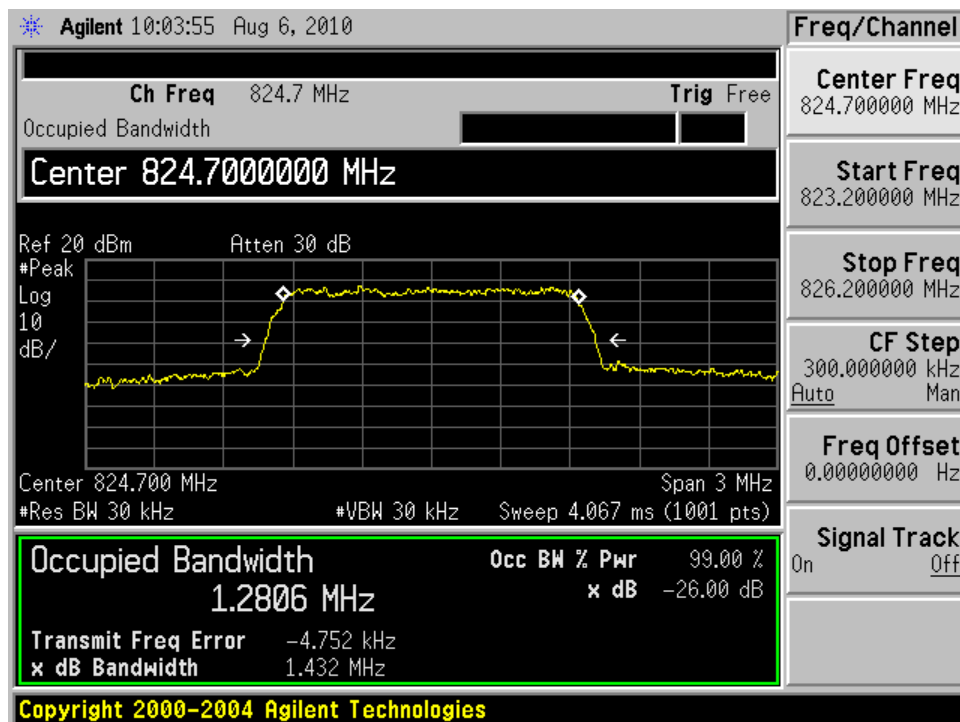
A.3 Occupied Bandwidth (§2.1049)

The resolution bandwidth was set to about 1% of emission bandwidth, -26dBc display line was placed on the screen (or 99% bandwidth), the occupied bandwidth is the delta frequency between the two points where the display line intersects the signal trace.

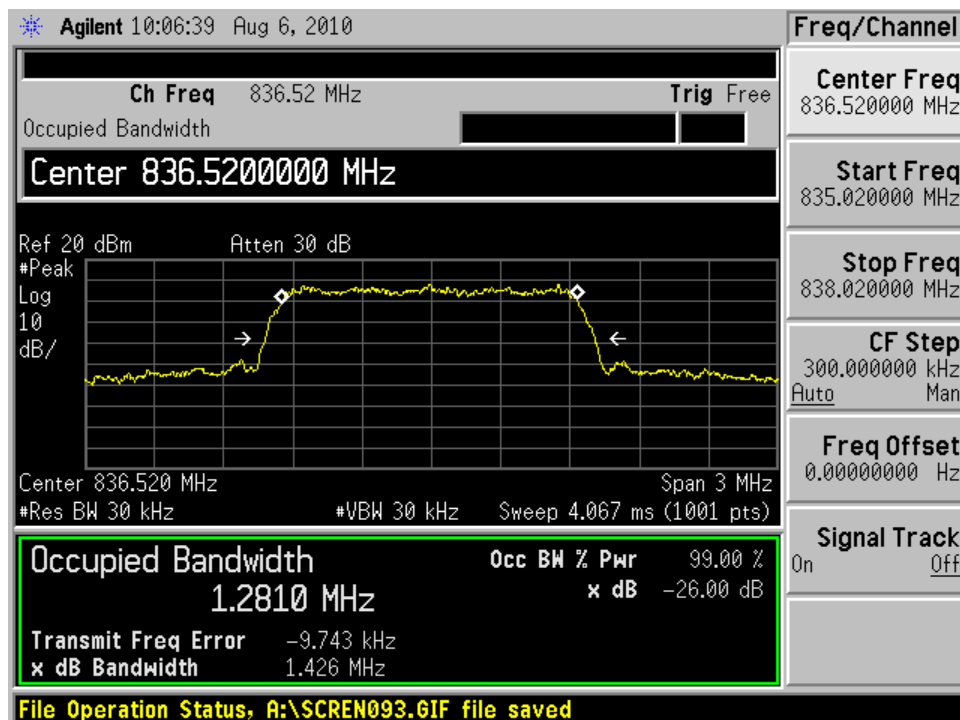
Test Date : August 6, 2010Temp.:26°C, Humi:51%

Channel	Frequency (MHz)	99% Bandwidth (MHz)	-26dBc Bandwidth (MHz)
1013	824.70	1.28	1.43
384	836.52	1.28	1.43
779	848.37	1.28	1.43

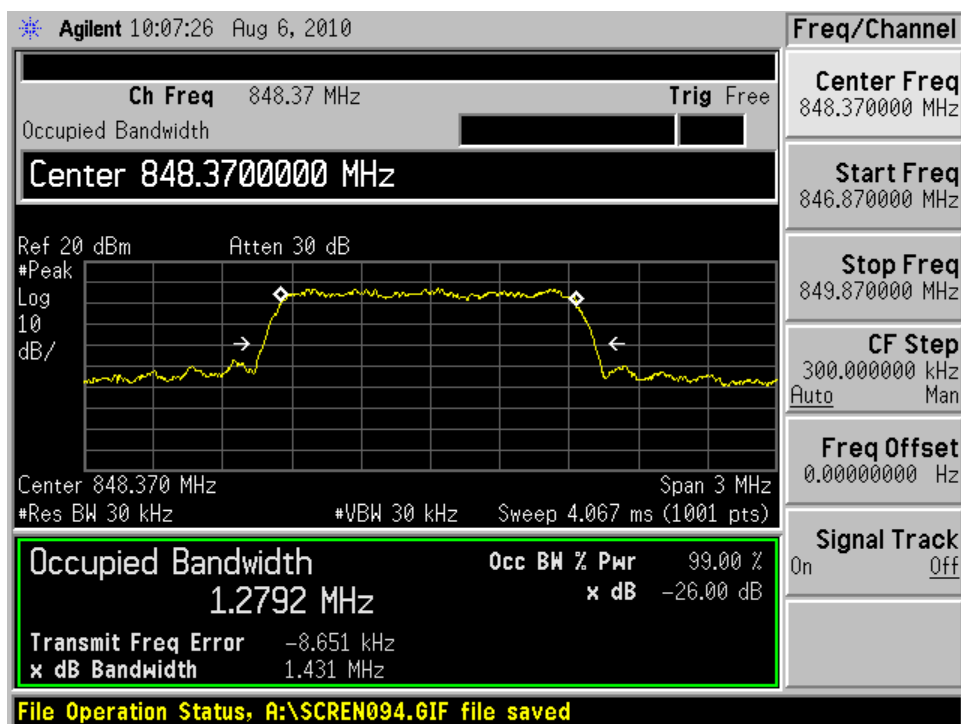
Low Channel



Middle Channel



High Channel



A.4 Spurious Emissions at Antenna Terminals (§2.1051)

(CDMA2000)

Test Date: August 6, 2010
 Temp.: 26 °C, Humi: 51 %

CH	Transmitting Frequency [MHz]	Measured Frequency [MHz]	Corr. Factor [dB]	Meter Readings [dBm]	Limits [dBm]	Results [dBm]	Margin [dB]	Remarks
1013	824.700	1649.400	12.4	< -63.0	-13.0	< -50.6	> +37.6	C
		2474.100	12.8	-45.4	-13.0	-32.6	+19.6	C
		3298.800	14.0	< -63.0	-13.0	< -49.0	> +36.0	C
		4123.500	15.4	< -63.0	-13.0	< -47.6	> +34.6	C
		4948.200	16.2	< -63.0	-13.0	< -46.8	> +33.8	C
		5772.900	17.1	< -63.0	-13.0	< -45.9	> +32.9	C
		6597.600	16.2	< -63.0	-13.0	< -46.8	> +33.8	C
		7422.300	16.6	< -63.0	-13.0	< -46.4	> +33.4	C
		8247.000	18.8	< -63.0	-13.0	< -44.2	> +31.2	C
384	836.520	1673.040	12.5	-62.5	-13.0	-50.0	+37.0	C
		2509.560	12.8	-46.1	-13.0	-33.3	+20.3	C
		3346.080	14.1	< -63.0	-13.0	< -48.9	> +35.9	C
		4182.600	15.5	< -63.0	-13.0	< -47.5	> +34.5	C
		5019.120	16.3	< -63.0	-13.0	< -46.7	> +33.7	C
		5855.640	17.1	< -63.0	-13.0	< -45.9	> +32.9	C
		6692.160	16.1	< -63.0	-13.0	< -46.9	> +33.9	C
		7528.680	16.8	< -63.0	-13.0	< -46.2	> +33.2	C
		8365.200	19.2	< -63.0	-13.0	< -43.8	> +30.8	C
779	848.370	1696.740	12.5	-60.2	-13.0	-47.7	+34.7	C
		2545.110	12.9	-47.8	-13.0	-34.9	+21.9	C
		3393.480	14.2	< -63.0	-13.0	< -48.8	> +35.8	C
		4241.850	15.5	< -63.0	-13.0	< -47.5	> +34.5	C
		5090.220	16.3	< -63.0	-13.0	< -46.7	> +33.7	C
		5938.590	17.2	< -63.0	-13.0	< -45.8	> +32.8	C
		6786.960	15.9	< -63.0	-13.0	< -47.1	> +34.1	C
		7635.330	17.1	< -63.0	-13.0	< -45.9	> +32.9	C
		8483.700	19.5	-62.4	-13.0	-42.9	+29.9	C

Calculated result at 2474.1 MHz, as the worst point shown on underline:

Corr. Factor	=	12.8 dB
+) Meter Reading	=	-45.4 dBm
Result	=	-32.6 dBm

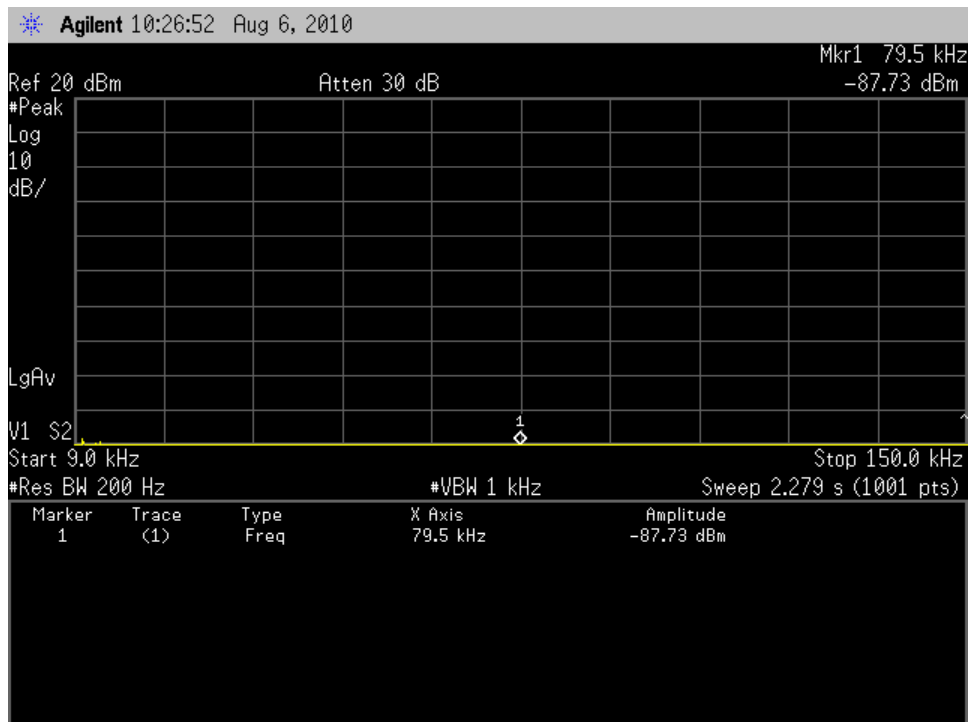
Minimum Margin: -13.0 - (-32.6) = 19.6 (dB)

NOTES

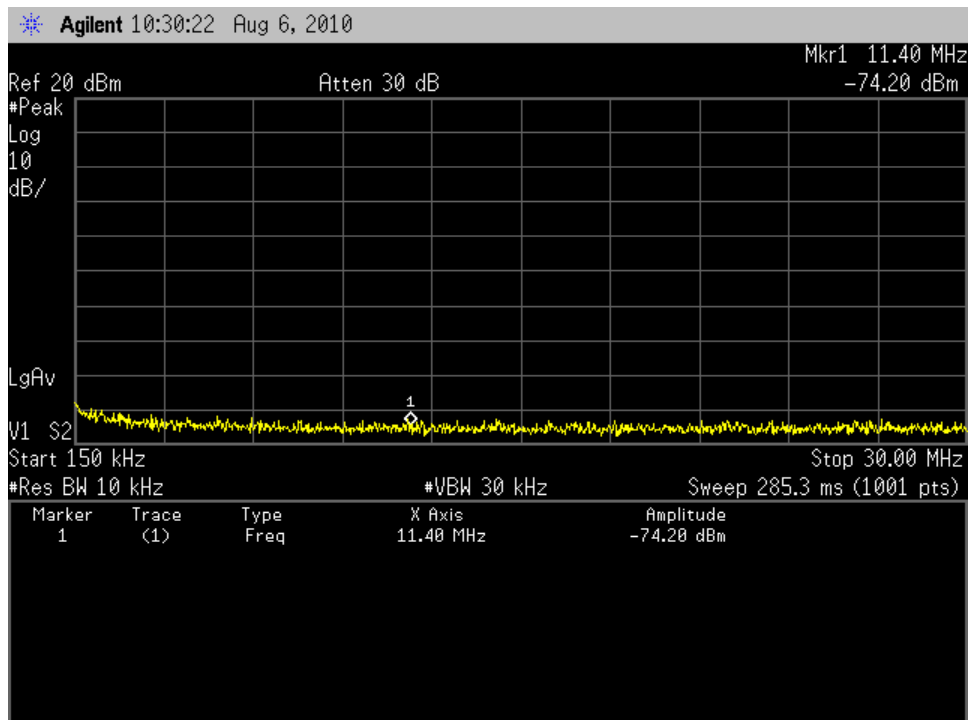
- The spectrum was checked from 9 kHz to 10 GHz.
- Applied limits : $-13.0 \text{ [dBm]} = 10\log(\text{TP[mW]}) - (43 + 10\log(\text{tp[W]})) = 10\log(\text{TP[mW]}) - (43 + (10 \log(\text{TP[mW]}) - 30))$
where, $\text{tp[W]} = \text{TP[mW]} / 1000$: Transmitter power at antenna terminal
- The correction factor is shown as follows:
Corr. Factor [dB] = Cable Loss + 10dB Pad Att. [dB] (9 kHz - 2 GHz)
Corr. Factor [dB] = Cable Loss + 10dB Pad Att. + High Pass Filter Loss (D-96) [dB] (over 2 GHz)
- The symbol of "<" means "or less".
- The symbol of ">" means "more than".
- Setting of measuring instrument(s) :

	Detector Function	RES B.W.	V.B.W.	Sweep Time
A	Peak	200 Hz	1 kHz	AUTO
B	Peak	10 kHz	30 kHz	AUTO
C	Peak	1 MHz	3 MHz	AUTO

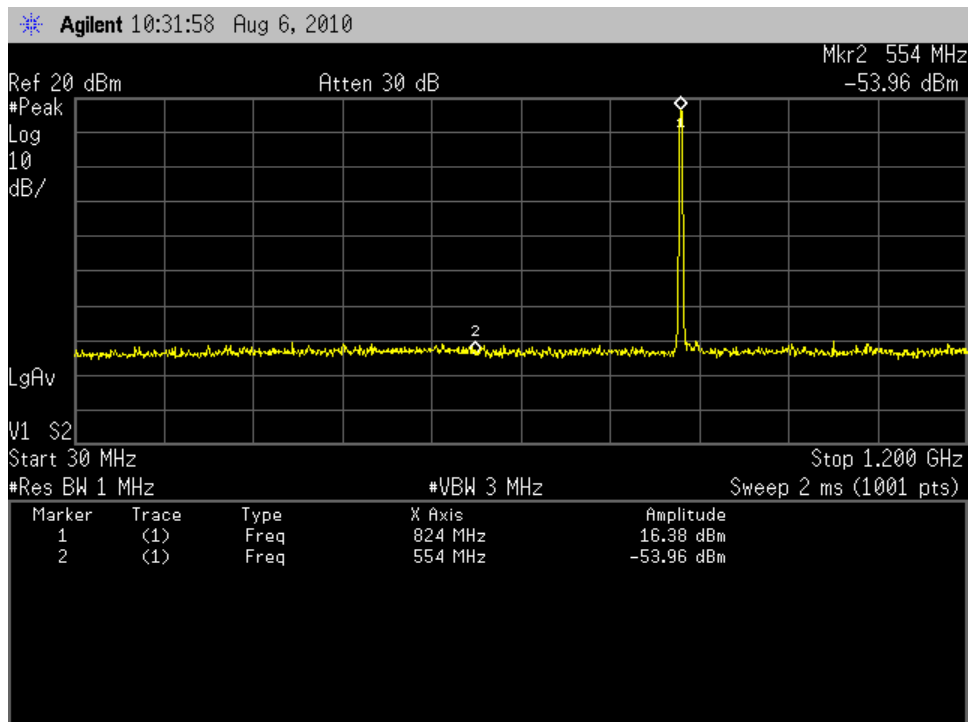
Low Channel, Out-Of-Band Emissions (9 kHz – 150 kHz)



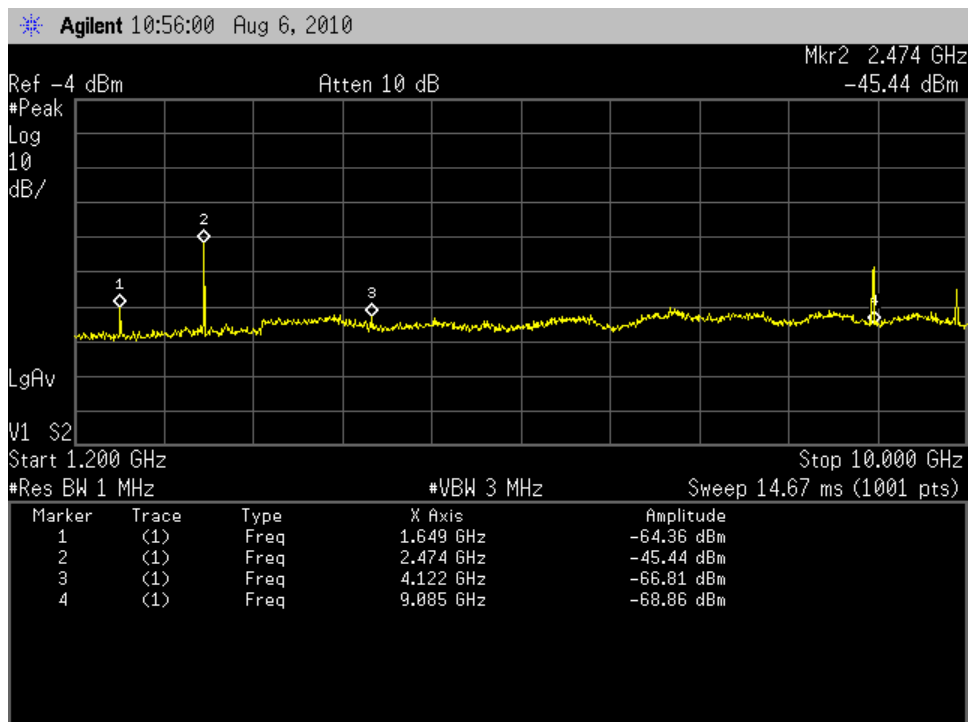
Low Channel, Out-Of-Band Emissions (150 kHz – 30 MHz)



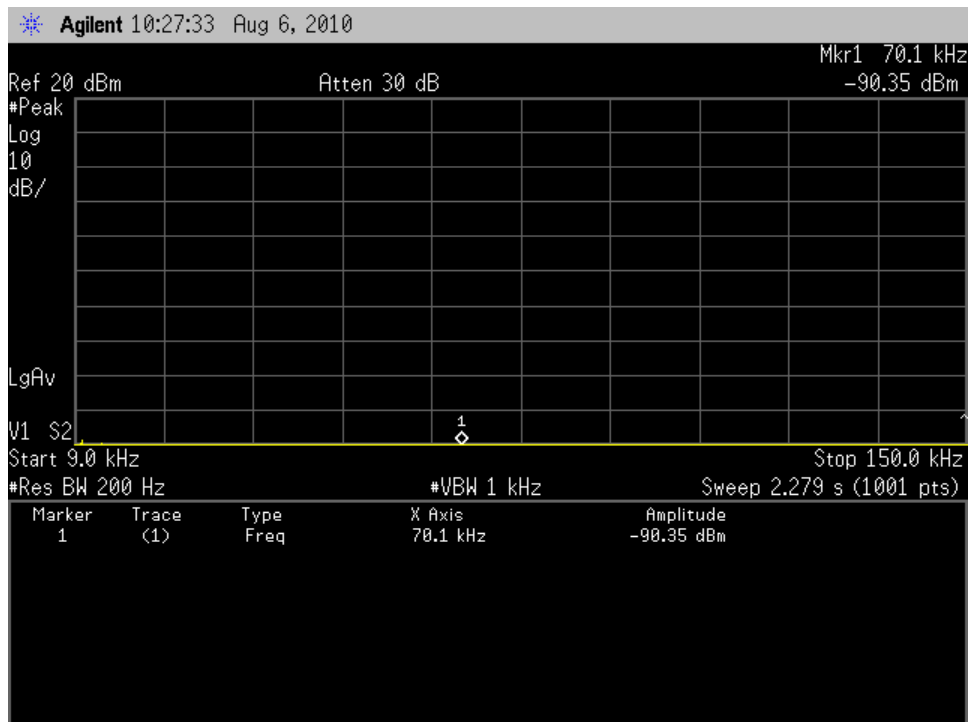
Low Channel, Out-Of-Band Emissions (30 MHz – 1.2 GHz)



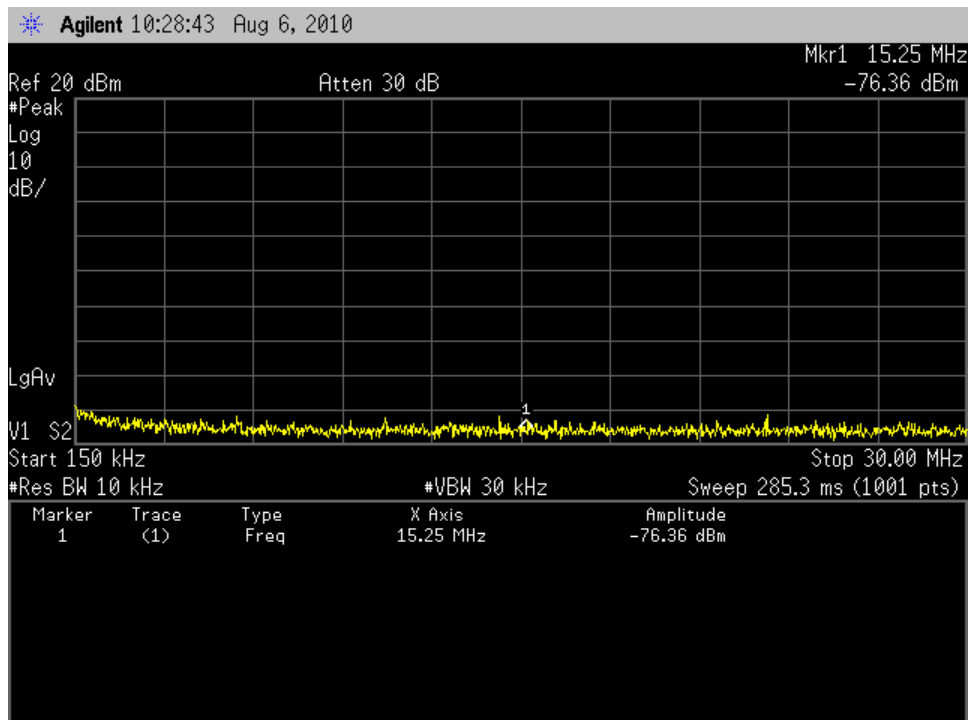
Low Channel, Out-Of-Band Emissions (1.2 GHz – 10 GHz)



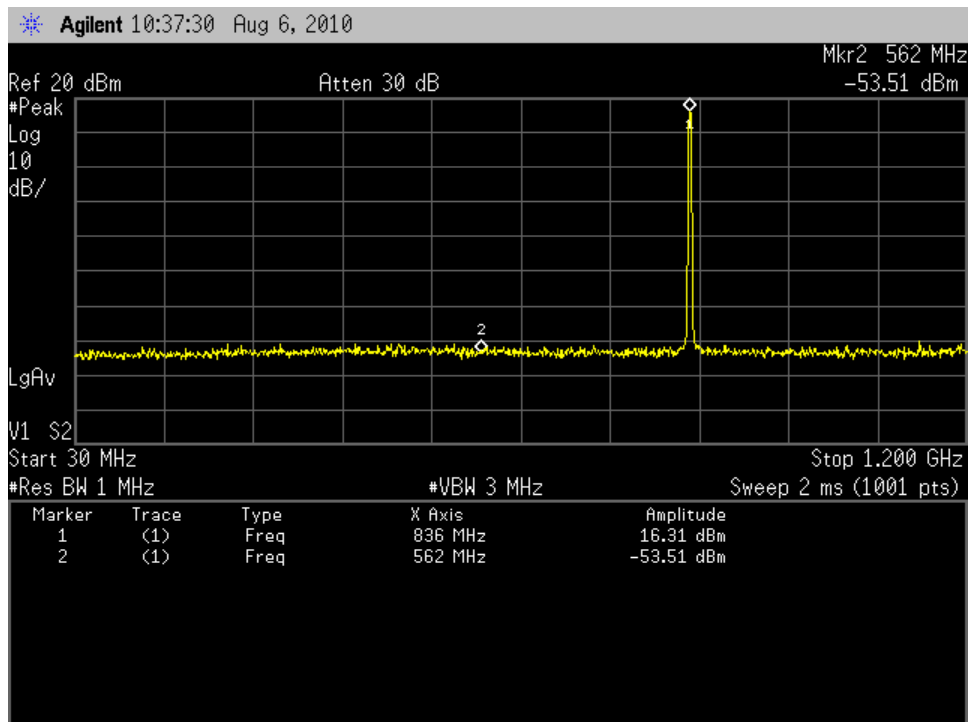
Middle Channel, Out-Of-Band Emissions (9 kHz – 150 kHz)



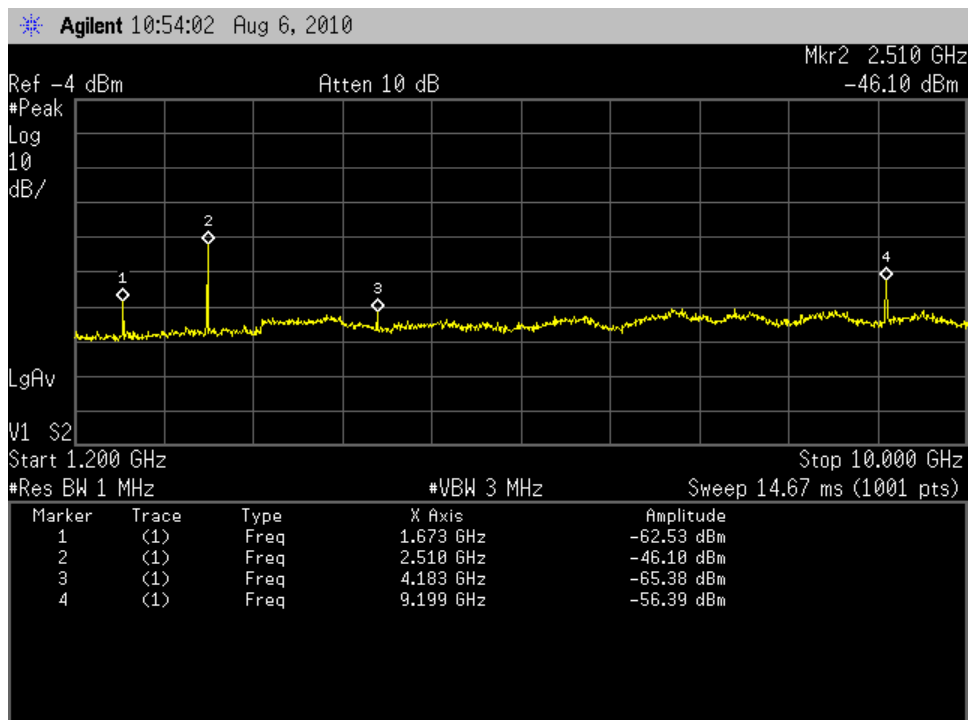
Middle Channel, Out-Of-Band Emissions (150 kHz – 30 MHz)



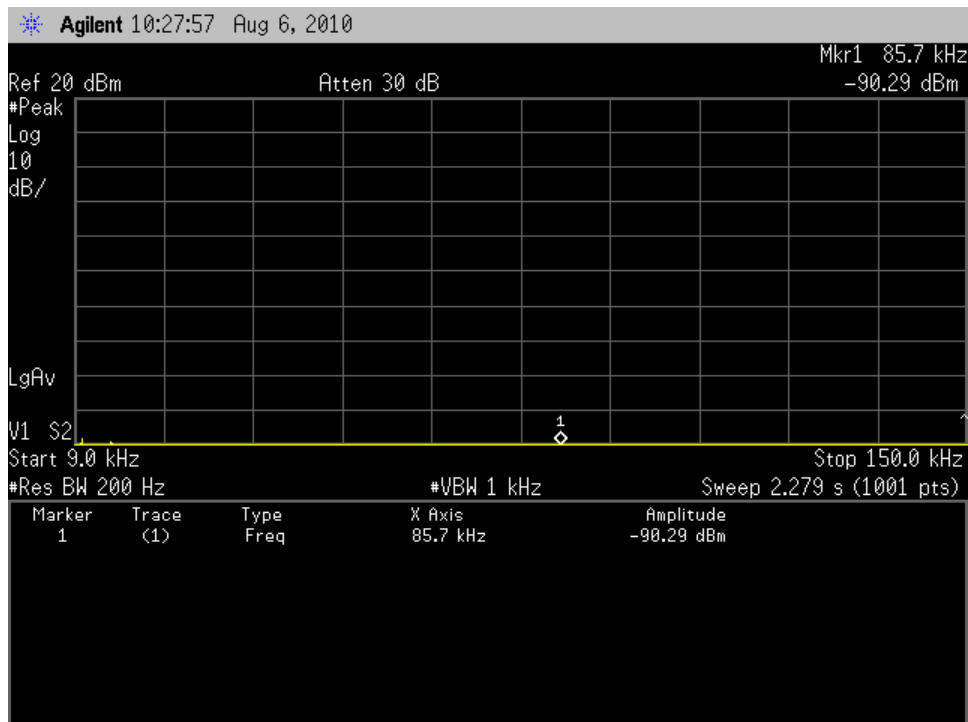
Middle Channel, Out-Of-Band Emissions (30 MHz – 1.2 GHz)



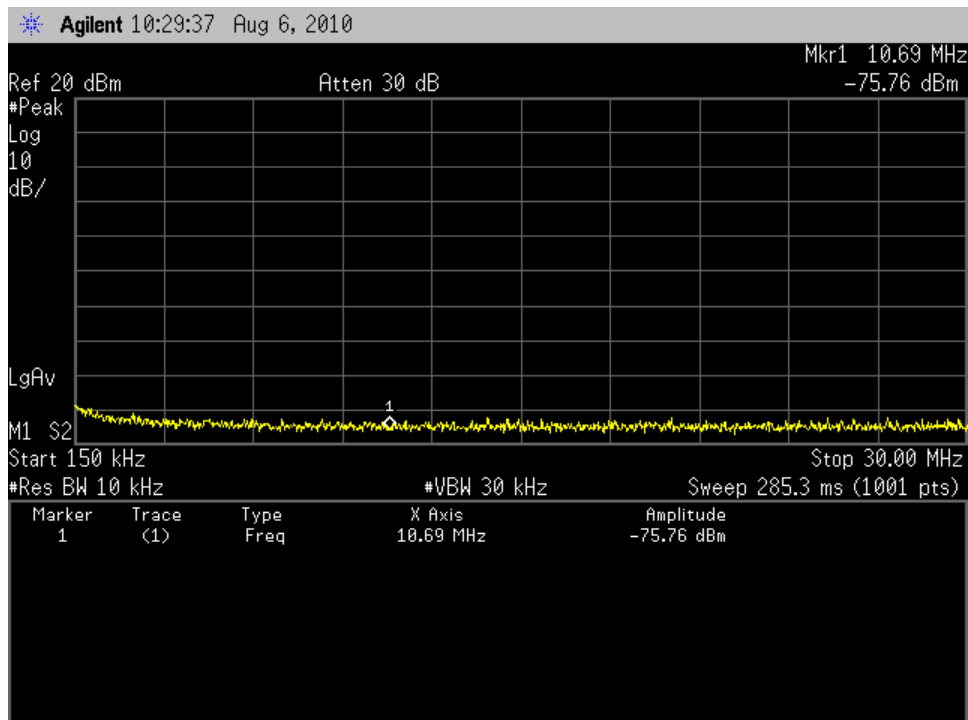
Middle Channel, Out-Of-Band Emissions (1.2 GHz – 10 GHz)



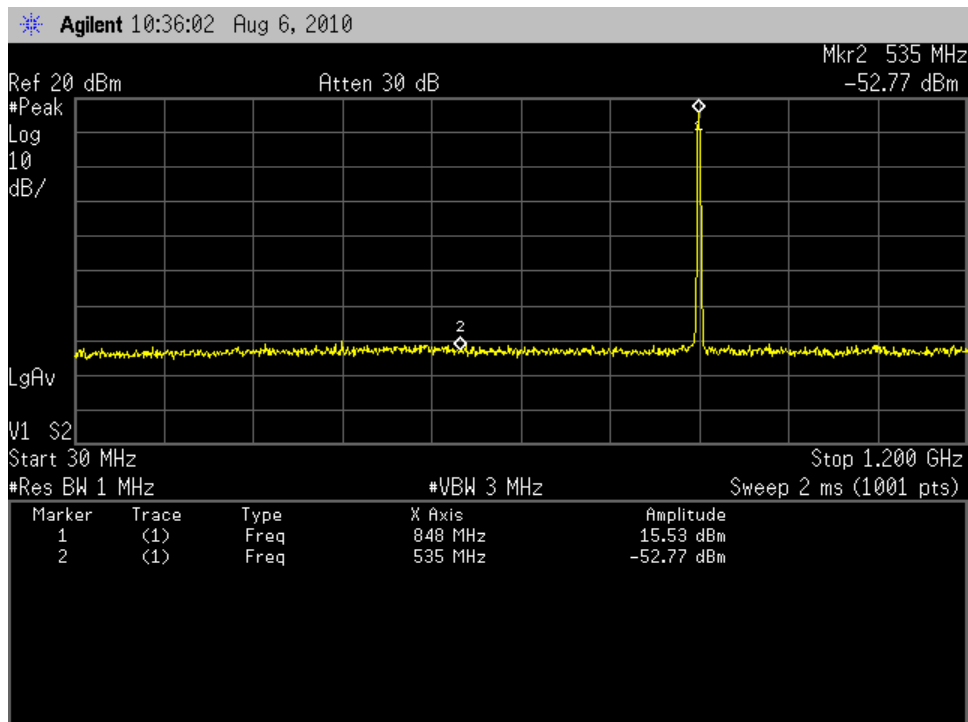
High Channel, Out-Of-Band Emissions (9 kHz – 150 kHz)



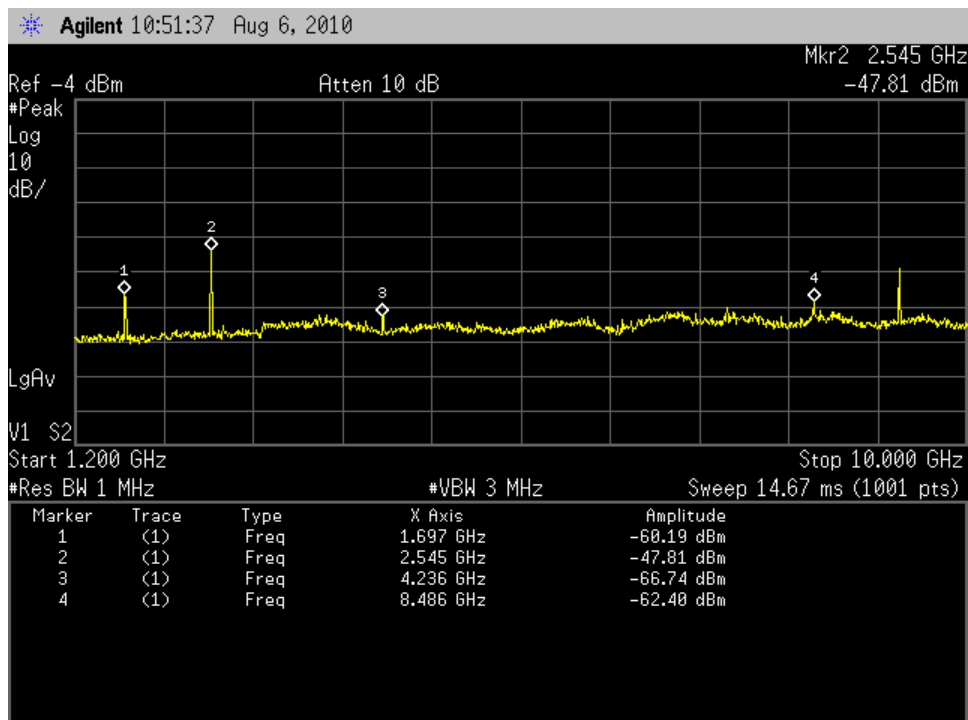
High Channel, Out-Of-Band Emissions (150 kHz – 30 MHz)



High Channel, Out-Of-Band Emissions (30 MHz – 1.2 GHz)



High Channel, Out-Of-Band Emissions (1.2 GHz – 10 GHz)

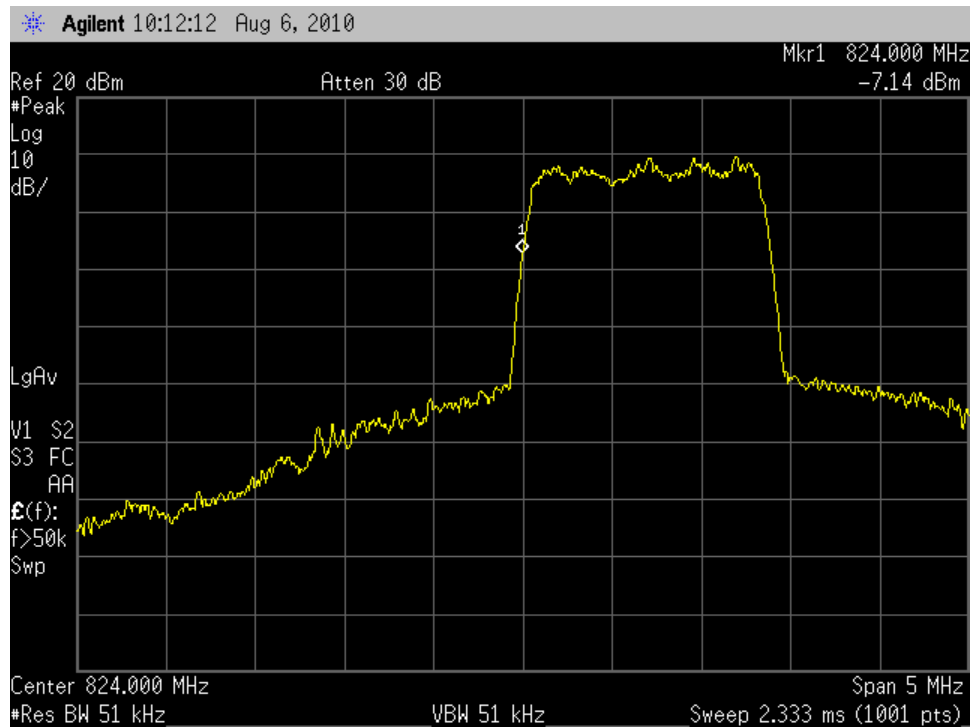


A.5 Band-Edge Emission(\$2.1051)

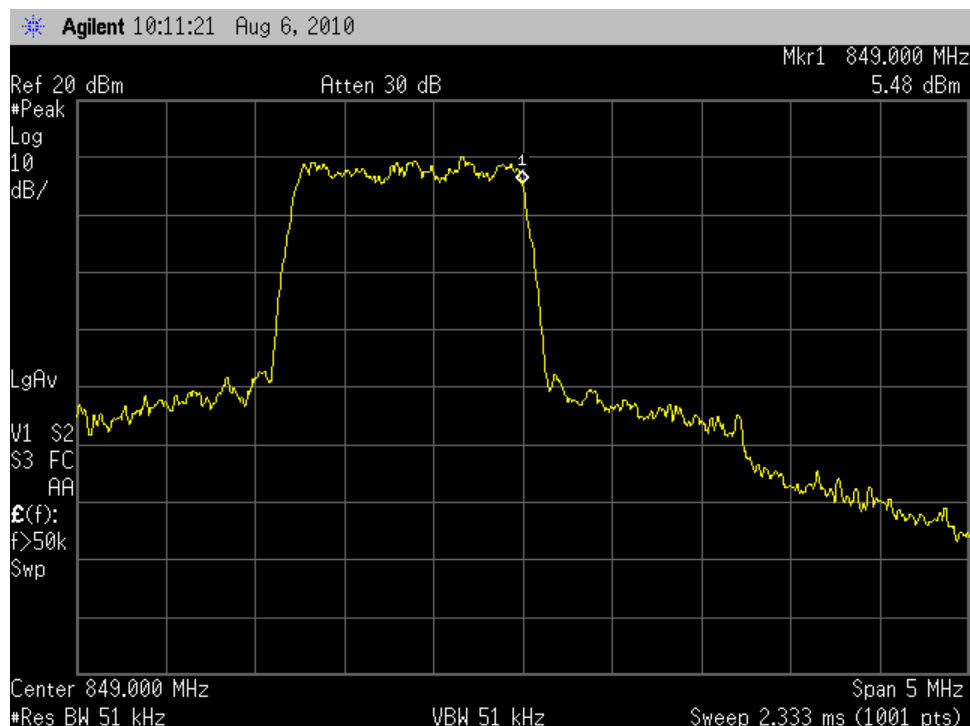
Test Date : August 6, 2010

Temp.:26°C, Humi:51%

Low Channel, Band-Edge Emission



High Channel, Band-Edge Emission



A.6 Field Strength of Spurious Radiation (§2.1053)

(CDMA2000)

Test Configuration : Single Unit

Test Date: August 13, 2010
 Temp.: 26 °C, Humi: 54 %
 Test Date: August 19, 2010
 Temp.: 26 °C, Humi: 51 %

CH	Transmitting Frequency [MHz]	Measured Frequency [MHz]	ERP [dBm]		Limits [dBm]	Margin [dB]	Remarks
			Hori.	Vert.			
1013	824.700	1649.400	-46.2	-45.8	-13.0	+32.8	C
		2474.100	-38.8	-41.6	-13.0	+25.8	C
		3298.800	-38.5	-43.1	-13.0	+25.5	C
		4123.500	-42.6	-46.4	-13.0	+29.6	C
		4948.200	-45.2	-42.8	-13.0	+29.8	C
		5772.900	< -50.1	< -50.1	-13.0	> +37.1	C
		6597.600	< -47.3	< -47.3	-13.0	> +34.3	C
		7422.300	< -56.7	< -56.7	-13.0	> +43.7	C
		8247.000	< -50.5	< -50.5	-13.0	> +37.5	C
384	836.520	1673.040	-46.5	-46.7	-13.0	+33.5	C
		2509.560	-38.6	-43.4	-13.0	+25.6	C
		3346.080	-37.7	-44.1	-13.0	+24.7	C
		4182.600	-43.8	-45.2	-13.0	+30.8	C
		5019.120	-46.5	-45.7	-13.0	+32.7	C
		5855.640	< -50.0	< -50.0	-13.0	> +37.0	C
		6692.160	< -47.3	< -47.3	-13.0	> +34.3	C
		7528.680	< -56.7	< -56.7	-13.0	> +43.7	C
		8365.200	< -50.4	< -50.4	-13.0	> +37.4	C
779	848.370	1696.740	-47.1	-46.0	-13.0	+33.0	C
		2545.110	-42.0	-45.7	-13.0	+29.0	C
		3393.480	-44.5	-43.3	-13.0	+30.3	C
		4241.850	-43.8	-43.8	-13.0	+30.8	C
		5090.220	-49.2	-47.1	-13.0	+34.1	C
		5938.590	< -49.9	< -49.9	-13.0	> +36.9	C
		6786.960	< -47.3	< -47.3	-13.0	> +34.3	C
		7635.330	< -54.6	< -54.6	-13.0	> +41.6	C
		8483.700	< -50.4	< -50.4	-13.0	> +37.4	C

Calculated result at 3346.1 MHz, as the worst point shown on underline:
Minimum Margin: $-13.0 - (-37.7) = 24.7$ (dB)

NOTES

1. Test Distance : 3 m
2. The spectrum was checked from 30 MHz to 10 GHz.
3. All emissions not reported were more than 20 dB below the applied limits.
4. Applied limits : -13.0 [dBm] = $10\log(TP[mW]) - (43 + 10\log(tp[W])) = 10\log(TP[mW]) - (43 + (10\log(TP[mW]) - 30))$
where, $tp[W] = TP[mW] / 1000$: Transmitter power at antenna terminal
5. The symbol of "<" means "or less".
6. The symbol of ">" means "more than".
7. Setting of measuring instrument(s) :

	Detector Function	RES B.W.	V.B.W.	Sweep Time
A	Peak	10 kHz	30 kHz	20 msec.
B	Peak	100 kHz	300 kHz	20 msec.
C	Peak	1 MHz	3 MHz	20 msec.

A.7 Frequency Stability (§2.1055)

(CDMA2000)

Test Date: July 26, 2010
 - July 27, 2010

1. Frequency Stability Measurement versus Temperature

Transmitting Frequency : 836.520 MHz (384 ch)
 DC Supply Voltage : 4.0 VDC

Ambient Temperature [°C]	Startup	Deviation [ppm]			Limits [ppm]	Margin [ppm]
		2 minutes	5 minutes	10 minutes		
-30	<u>+ 0.05</u>	- 0.04	<u>- 0.05</u>	+ 0.03	2.50	2.45
-20	- 0.04	+ 0.04	- 0.04	- 0.04	2.50	2.46
-10	<u>+ 0.05</u>	- 0.03	- 0.04	<u>- 0.05</u>	2.50	2.45
0	- 0.03	+ 0.04	+ 0.03	- 0.04	2.50	2.46
10	- 0.04	<u>- 0.05</u>	- 0.04	+ 0.04	2.50	2.45
20	+ 0.03	+ 0.01	+ 0.00	+ 0.00	2.50	2.47
30	- 0.01	+ 0.02	+ 0.01	+ 0.00	2.50	2.48
40	<u>- 0.05</u>	+ 0.00	- 0.01	+ 0.01	2.50	2.45
50	+ 0.01	+ 0.02	- 0.01	+ 0.00	2.50	2.48

2. Frequency Stability Measurement versus Power Supply Voltage

Transmitting Frequency : 836.520 MHz (384 ch)
 Ambient Temperature: : 20 °C

DC Supply Voltage [V]	Startup	Deviation [ppm]			Limits [ppm]	Margin [ppm]
		2 minutes	5 minutes	10 minutes		
4.0	+ 0.03	+ 0.01	+ 0.00	+ 0.00	2.50	2.47
3.7 (Ending)	+ 0.02	+ 0.04	+ 0.01	+ 0.00	2.50	2.46

Test condition example as the maximum deviation point shown on underline:

Ambient Temperature : -30 °C / Startup

DC Supply Voltage : 4 VDC

Minimum Margin: 2.50 - 0.05 = 2.45 (ppm)

NOTE : The measurement were made after all of components of the oscillator sufficiently stabilized at each temperature.

Appendix B: Test Arrangement (Photographs)**Radiated Emission**

This page is CONFIDENTIAL.

This page is CONFIDENTIAL.

Appendix C: Test Instruments

C.1 RF Power Output

C.1.1 Conducted RF Power Output

Type	Model	Manufacturer	ID No.	Last Cal.	Interval
Power Meter	N1911A	Agilent	B-63	2010/6	1 Year
Power Sensor	N1921A	Agilent	B-64	2010/6	1 Year
Attenuator	54A-10	Weinschel	D-29	2009/9	1 Year
RF Cable	SUCOFLEX102	SUHNER	C-52	2010/6	1 Year

C.1.2 ERP /EIRP Power Output

Type	Model	Manufacturer	ID No.	Last Cal.	Interval
Test Receiver	ESCI	Rohde & Schwartz	A-42	2009/11	1 Year
Signal Generator	E8257D	Agilent	B-39	2009/8	1 Year
Power Meter	N1911A	Agilent	B-63	2010/6	1 Year
Power Sensor	N1921A	Agilent	B-64	2010/6	1 Year
Attenuator(TX)	2-10	Weinschel	D-79	2009/9	1 Year
Dipole Antenna(RX)	KBA-611	Kyoritsu	C-20	2009/8	2 Years
Dipole Antenna(TX)	KBA-611	Kyoritsu	C-19	2009/8	2 Years

C.2 Modulation Characteristics

Not Applicable

C.3 Occupied Bandwidth

Type	Model	Manufacturer	ID No.	Last Cal.	Interval
Spectrum Analyzer	E4446A	Agilent	A-39	2010/1	1 Year
Attenuator	54A-10	Weinschel	D-29	2009/9	1 Year
RF Cable	SUCOFLEX102	SUHNER	C-52	2010/6	1 Year

C.4 Spurious Emissions at Antenna Terminals

Type	Model	Manufacturer	ID No.	Last Cal.	Interval
Spectrum Analyzer	E4446A	Agilent	A-39	2010/1	1 Year
Attenuator	54A-10	Weinschel	D-29	2009/9	1 Year
RF Cable	SUCOFLEX102	SUHNER	C-52	2010/6	1 Year
HPF	HPM5010S	MICRO-TRONICS	D-94	2010/2	1 Year

Type	Model	Manufacturer	ID No.	Last Cal.	Interval
Spectrum Analyzer	E4446A	Agilent	A-39	2010/1	1 Year
Attenuator	54A-10	Weinschel	D-29	2009/9	1 Year
RF Cable	SUCOFLEX102	SUHNER	C-52	2010/6	1 Year

C.5 Band-Edge Emission

Type	Model	Manufacturer	ID No.	Last Cal.	Interval
Spectrum Analyzer	E4446A	Agilent	A-39	2010/1	1 Year
Attenuator	54A-10	Weinschel	D-29	2009/9	1 Year
RF Cable	SUCOFLEX102	SUHNER	C-52	2010/6	1 Year

C.6 Field Strength of Spurious Radiation

Type	Model	Manufacturer	ID No.	Last Cal.	Interval
Spectrum Analyzer	E4446A	Agilent	A-39	2010/1	1 Year
Spectrum Analyzer	N9010A (S/N:MY47191105)	Agilent	--	2010/5	1 Year
Signal Generator	E8257A	Agilent	B-39	2009/8	1 Year
Power Meter	N1911A	Agilent	B-63	2010/6	1 Year
Power Sensor	N1921A	Agilent	B-64	2010/6	1 Year
Horn Antenna(TX)	91888-2	EATON	C-40-1	2009/6	2 Years
Horn Antenna(TX)	91889-2	EATON	C-40-2	2009/6	2 Years
Horn Antenna(TX)	94613-1	EATON	C-41-3	2010/6	1 Year
Horn Antenna(TX)	91891-2	EATON	C-41-4	2010/6	1 Year
Horn Antenna(RX)	91888-2	EATON	C-41-1	2010/6	1 Year
Horn Antenna(RX)	91889-2	EATON	C-41-2	2010/8	1 Year
Horn Antenna(RX)	3160-05	EATON	C-56	2009/6	2 Years
Horn Antenna(RX)	3160-06	EATON	C-57	2009/6	2 Years
Horn Antenna(RX)	3160-07	EATON	C-58	2009/6	2 Years
RF Cable(TX)	SUCOFLEX E102E	SUHNER	C-70	2009/11	1 Year
RF Cable(RX)	SUCOFLEX104	SUHNER	C-40-11	2010/1	1 Year
RF Cable(RX)	SUCOFLEX104	SUHNER	C-40-14	2010/1	1 Year
Attenuator(TX)	2-10	Weinschel	D-40	2009/8	1 Year
Attenuator(RX)	2-10	Weinschel	D-79	2009/9	1 Year
Attenuator(RX)	54-10	Weinschel	D-82	2010/6	1 Year
Pre-Amplifier	WJ-6611-513	Watkins Johnson	A-23	2010/1	1 Year
Pre-Amplifier	WJ-6882-824	Watkins Johnson	A-21	2010/1	1 Year
Pre-Amplifier	DBL-0618N515	DBS Microwave	A-33	2010/1	1 Year

C.7 Frequency Stability

Type	Model	Manufacturer	ID No.	Last Cal.	Interval
Universal Telecommunication Tester	CMU200	Rohde&Schwarz	B-21	2010/4	1 Year
DC Voltage Meter	2011-39	YEW	B-33	2010/4	1 Year
Environmental Chamber	PL-4KPH (S/N:14007470)	TABAI ESPEC	--	N/A	N/A
Temperature Recorder	SRF106AS00000M11 (S/N:01400909)	TABAI ESPEC	--	2009/8	1 Year
DC Power Supply	NL035-10	TAKASAGO	F-4	N/A	N/A